

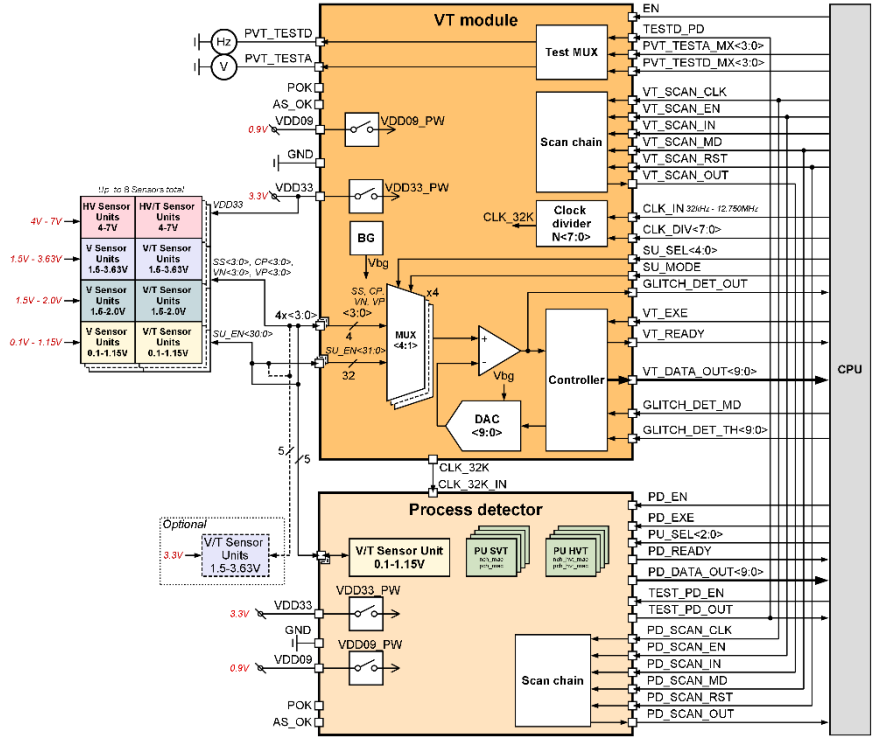
## PVT Detector OVERVIEW

028TSMC\_PVT\_04 is a unique solution intended to continuously monitor IC status at several on-die locations. It is able to detect manufacturing process deviation, perform voltage and die temperature measurement. PVT Detector consists of VT module as a calculation center for voltage and temperature measurements, Process detector with process unit for standard-voltage, low-voltage and high-voltage threshold MOS transistors and IO 2.5V transistor, voltage/temperature sensor units and voltage sensor units. VT module is able to maintain up to 32 external voltage and voltage/temperature sensor units of four types in any variations: for Core voltage measurement range from 0.1V to 1.15V, for IO voltage measurement range from 1.5V÷2.0V, for IO voltage measurement range from 1.5V÷3.63V and additional 4.0V÷7.0V IO voltage measurement range. Process detector embeds VT sensor unit for Core voltage measurement and can be placed on the die in quantity up to 31 cells

IP technology: TSMC 28nm eFlash.

IP status: pre-silicon verification.

Silicon area: VT module – 0.1151mm<sup>2</sup>; Process detector – 0.005016mm<sup>2</sup>; Sensor Units for 0.9V/1.8V/3.3V/5V temperature/voltage measurement – 0.001514mm<sup>2</sup>/ 0.001895mm<sup>2</sup>/ 0.002795mm<sup>2</sup>/ 0.003485mm<sup>2</sup>; Sensor Units for 0.9V/1.8V/3.3V/5V voltage measurement – 0.000648mm<sup>2</sup>/ 0.001041mm<sup>2</sup>/ 0.001767mm<sup>2</sup>/ 0.002571mm<sup>2</sup>.



## ELECTRICAL CHARACTERISTICS

Parameter	Symbol	Conditions	Value			Units	
			min	typ.	max		
Core supply voltage	V <sub>DD09</sub>	-	0.81	0.9	0.99	V	
IO supply voltage	V <sub>DD33</sub>	-	2.97	3.3	3.63	V	
Operating temperature range	T <sub>j</sub>	-	-40	27	150	°C	
Voltage measurement range	V <sub>MR09</sub>	For 0.9V VT sensor unit	0.1	-	1.15	V	
	V <sub>MR18</sub>	For 1.8V VT sensor unit	1.5	-	2.0	V	
	V <sub>MR33</sub>	For 3.3V VT sensor unit	1.5	-	3.63	V	
	V <sub>MR5</sub>	For 5.0V VT sensor unit	4	-	7	V	
Output DATA resolution	K	-	-	10	-	bit	
Clock frequency	F <sub>CLK</sub>	-	-	32	-	kHz	
Current consumption	I <sub>CCVDD09_VT</sub>	In case of V/T measurement	@AVDD09	-	0.2	31	uA
			@AVDD33	-	323	399	
	I <sub>CCVDD33_P</sub>	In case of Process detection	@AVDD09	-	200	250	uA
			@AVDD33	-	5	10	
Shutdown current	I <sub>CCSTD_VDD09</sub>	@AVDD09	-	0.1	2.31	uA	
	I <sub>STD_VDD33</sub>	@AVDD33	-	0.1	0.97	uA	
Bandgap voltage	V <sub>BG</sub>	-	796	805	815	mV	
Voltage measurement inaccuracy for 0.9V VT sensor unit	A <sub>V_MR09</sub>	Without trimming	δ	-	-	0.6	%
			3δ	-	-	2.0	
Voltage measurement inaccuracy for 1.8V VT sensor unit	A <sub>V_MR18</sub>	Without trimming	δ	-	-	0.6	%
			3δ	-	-	1.9	
Voltage measurement inaccuracy for 3.3V VT sensor unit	A <sub>V_MR33</sub>	Without trimming	δ	-	-	0.9	%
			3δ	-	-	2.9	

Parameter	Symbol	Conditions	Value			Units	
			min	typ.	max		
Voltage measurement inaccuracy for 5.0V VT sensor	$A_{V\_MR5}$	Without trimming	$\delta$	-	-	0.8	%
			$3\delta$	-	-	2.9	
Temperature measurement range	$T_{MR}$	-	-40	-	150	°C	
Temperature measurement accuracy	$A_T$	Without trimming	$\delta$	-	-	2.2	°C
			$3\delta$	-	-	6.6	
		With trimming	$\delta$	-	-	0.4	
			$3\delta$	-	-	0.8	